

**Notice of References Cited**

 Application/Control No.  
 09/758,942

 Applicant(s)/Patent Under  
 Reexamination  
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 Art Unit  
 3629  
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.